

**Nanotechnology for forensic sciences: Analysis of PDMS replica of the case head of spent cartridges by optical microscopy, SEM and AFM for the ballistic identification of individual characteristic features of firearms**

Valle F, Bianchi M, Tortorella S, Pierini G, Biscarini F, D'Elia M.

Forensic science international

2012; 222(1-3):288-297

**ARTICLE IDENTIFIERS**

DOI: 10.1016/j.forsciint.2012.07.005

PMID: 22840283

PMCID: not available

**JOURNAL IDENTIFIERS**

LCCN: not available

pISSN: 0379-0738

eISSN: 1872-6283

OCLC ID: not available

CONS ID: not available

US National Library of Medicine ID: not available

This article was identified from a query of the SafetyLit database.